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Application/Control	No.

Applicant(s)/Patent under Reexamination RUTTER, DAVID

10/700,953 Examiner

Art Unit 2875

Jason M. Han

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	CH NOTES EARCH STRATEGY)
	DATE	EXM
Search History	2/22/2005	ЈМН
P.E. John Ward	2/22/2005	JMH

SEARCHED				
Class	Subclass	Date	Examiner	
362	34, 84	2/22/2005	JMH	
362	249	2/22/2005	ЈМН	
362	252	2/22/2005	ЈМН	
362	333	2/22/2005	ЈМН	
362	540	2/22/2005	ЈМН	

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Class	Subclass	Date	Examiner		
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